# FDS6682

FAIRCHILD SEMICONDUCTOR

## 30V N-Channel PowerTrench<sup>o</sup> MOSFET

### **General Description**

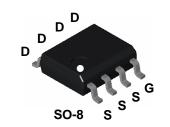
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

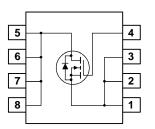
## Applications

• DC/DC converter

## Features

- 14 A, 30 V.  $R_{DS(ON)}$  = 7.5 m $\Omega$  @ V<sub>GS</sub> = 10 V  $R_{DS(ON)}$  = 9.0 m $\Omega$  @ V<sub>GS</sub> = 4.5 V
- Low gate charge (22 nC typical)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A=25°C</sub> unless otherwise noted

Symbol		Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain-Source	rce Voltage		30	V	
V <sub>GSS</sub>	Gate-Sourc	rce Voltage		±20	V	
I <sub>D</sub>	Drain Current – Continuous (M		(Note 1a)	14	А	
		- Pulsed		50		
P <sub>D</sub>	Power Dissipation for Single Operation		n (Note 1a)	2.5	W	
			(Note 1b)	1.2		
			(Note 1c)	1.0		
T <sub>J</sub> , T <sub>STG</sub>	Operating a	nd Storage Junction Temp	erature Range	-55 to +150	°C	
	I Charac				°C/W	
$R_{ ext{ hetaJA}}$	Thermal Resistance, Junction-to-Ambient (Note 1a)		ient (Note 1a)	50		
$R_{ ext{ ext{ ext{ ext{ ext{ ext{ ext{ ext$	Thermal Resistance, Junction-to-Case (Note 1)		e (Note 1)	25	°C/W	
		g and Ordering I				
	Marking	Device	Reel Size	Tape width	Quantity	
Device	•			12mm	2500 units	

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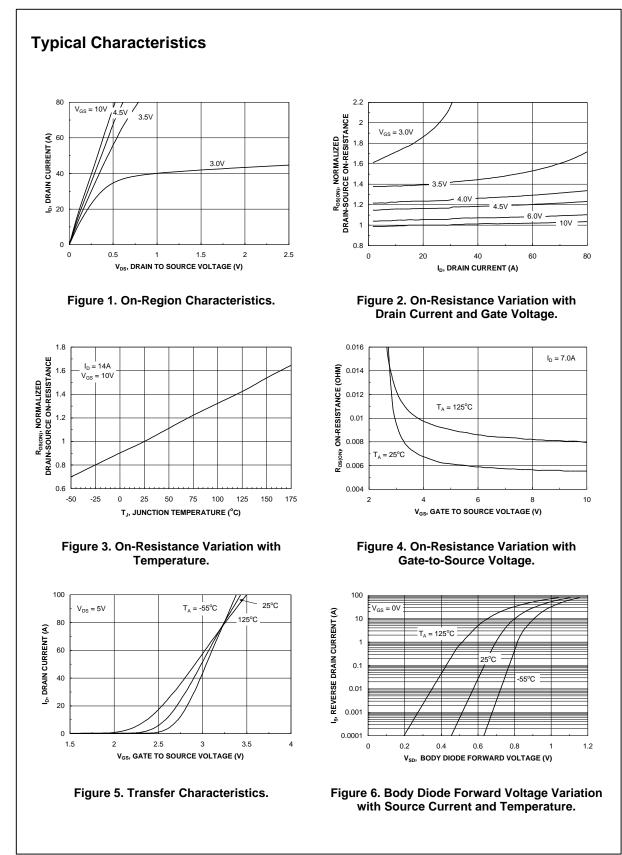
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			•		
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			10	μA
IGSSF	Gate–Body Leakage, Forward	$V_{GS} = 20 \text{ V},  V_{DS} = 0 \text{ V}$			100	nA
IGSSR	Gate–Body Leakage, Reverse	$V_{\text{GS}} = -20 \text{ V},  V_{\text{DS}} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)			•		•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.7	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 µA, Referenced to 25°C		-5.6		mV/°0
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 10 \; V, & I_D = 14 \; A \\ V_{GS} = 4.5 \; V, & I_D = 12.5 \; A \\ V_{GS} = 4.5 \; V, \; I_D = 12.5 \; A, \; T_J \!=\! 125^\circ \! C \\ \end{array} $		5.7 6.6 8	7.5 9 11.5	mΩ
I <sub>D(on)</sub>	On–State Drain Current	$V_{GS} = 10 \text{ V},  V_{DS} = 5 \text{ V}$	50			Α
<b>g</b> fs	Forward Transconductance	$V_{DS} = 10 V$ , $I_D = 14 A$		70		S
Dynamic	Characteristics					
	Input Capacitance	$V_{DS} = 15 \text{ V},  V_{GS} = 0 \text{ V},$		2310		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0  MHz		582		pF
	Reverse Transfer Capacitance			237		pF
	· ·		l			F.
	<b>IG Characteristics</b> (Note 2) Turn–On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		10	20	
t <sub>d(on)</sub>	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		10 7	20 14	ns
t <sub>r</sub>		-		44	70	ns
t <sub>d(off)</sub>	Turn–Off Delay Time Turn–Off Fall Time	_		16	29	ns ns
t <sub>f</sub>		V <sub>DS</sub> = 15 V, I <sub>D</sub> = 14 A,		22	31	-
Qg Qgs	Total Gate Charge Gate–Source Charge	$V_{GS} = 5 V$		6.4	31	nC nC
	Gate-Drain Charge	-		0.4 8		nC
	3			0		
Drain-So	ource Diode Characteristics				2.1	А
	Drain–Source Diode Forward					
V <sub>SD</sub>	Voltage	$V_{GS} = 0 V$ , $I_S = 2.1 A$ (Note 2)		0.7	1.2	V
otes: R <sub>eJA</sub> is the sun		mal resistance where the case thermal reference is				

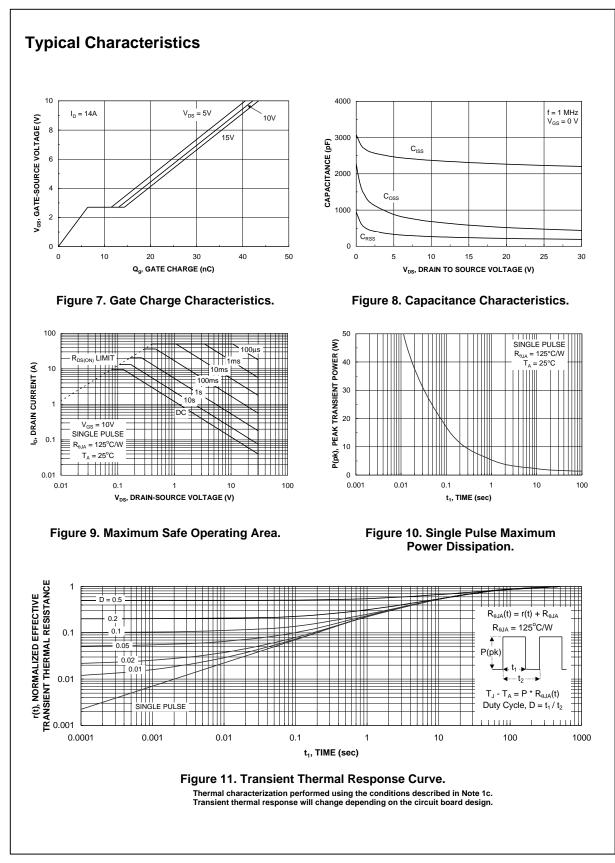
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Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu s,$  Duty Cycle < 2.0%



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FDS6682 Rev D(W)

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